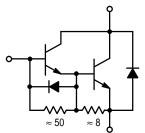
# Designer's™ Data Sheet

# SWITCHMODE Series NPN Silicon Power Darlington Transistors with Base-Emitter Speedup Diode

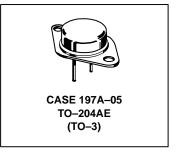
The BUT34 Darlington transistor is designed for high–voltage, high–speed, power switching in inductive circuits where fall time is critical. They are particularly suited for line–operated SWITCHMODE applications such as:

- AC and DC Motor Controls
- Switching Regulators
- Inverters
- · Solenoid and Relay Drivers
- Fast Turn–Off Times
  - 0.7  $\mu s$  Inductive Fall Time at 25 °C (Typ) 1.8  $\mu s$  Inductive Storage Time at 25 °C (Typ)
- Operating Temperature Range −65 to 200°C



# **BUT34**

50 AMPERES NPN SILICON POWER DARLINGTON TRANSISTOR 850 VOLTS 250 WATTS



### **MAXIMUM RATINGS**

Rating	Symbol	BUT34	Unit
Collector–Emitter Voltage	VCEO(sus)	500	Vdc
Collector–Emitter Voltage	VCEV	850	Vdc
Emitter–Base Voltage	V <sub>EB</sub>	10	Vdc
Collector Current — Continuous — Peak (1)	IC ICM	50 75	Adc
Base Current — Continuous — Peak (1)	I <sub>B</sub> I <sub>BM</sub>	10 15	Adc
Free Wheel Diode Forward Current — Continuous — Peak	lF IFM	50 75	Adc
Total Power Dissipation @ T <sub>C</sub> = 25°C @ T <sub>C</sub> = 100°C Derate above 25°C	PD	250 140	Watts W/°C
Operating and Storage Junction Temperature Range	T <sub>J</sub> , T <sub>stg</sub>	-65 to +200	°C

### THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Case	$R_{ heta JC}$	0.7	°C/W
Maximum Lead Temperature for Soldering Purpose: 1/8" from Case for 5 Seconds	TL	275	°C

(1) Pulse Test: Pulse Width = 5 ms, Duty Cycle  $\leq$  10%.

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**Designer's Data for "Worst Case" Conditions** — The Designer's Data Sheet permits the design of most circuits entirely from the information presented. SOA Limit curves — representing boundaries on device characteristics — are given to facilitate "worst case" design.

# REV 7



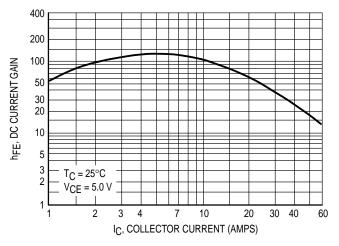
## **BUT34**

# **ELECTRICAL CHARACTERISTICS** ( $T_C = 25^{\circ}C$ unless otherwise noted)

	Characteristic		Symbol	Min	Тур	Max	Unit
OFF CHARACTER	ISTICS						
Collector–Emitter (I <sub>C</sub> = 100 mA,	-Emitter Sustaining Voltage (Table 1)			500	_	_	Vdc
Collector Cutoff C (V <sub>CEV</sub> = Rated (V <sub>CEV</sub> = Rated	Current d Value, V <sub>BE(off)</sub> = 1.5 Vdc) d Value, V <sub>BE(off)</sub> = 1.5 Vdc, To	C = 100°C)	ICEV			0.2 4.0	mAdc
	Emitter Cutoff Current (VEB = 2.0 V, IC = 0)			_	_	350	mAdc
SECOND BREAK	DOWN						
Second Breakdo	econd Breakdown Collector Current with base forward biased		I <sub>S/b</sub>		See Fig	gure 16	
Clamped Inductiv	e SOA with Base Reverse Bia	ased	RBSOA		See Figure 17		
ON CHARACTERI	STICS (1)						
DC Current Gain (I <sub>C</sub> = 16 A, V <sub>C</sub> (I <sub>C</sub> = 32 A, V <sub>C</sub>			hFE	30 15	_	_	
Collector-Emitter (I <sub>C</sub> = 16 A, I <sub>B</sub> = (I <sub>C</sub> = 32 A, I <sub>B</sub> = (I <sub>C</sub> = 40 A, I <sub>B</sub> = (I <sub>C</sub> = 50 A, I <sub>B</sub> =	= 3.2 A) = 4 A)		VCE(sat)	_ _ _ _		2.0 3.0 3.5 5.0	Vdc
Base–Emitter Sa (I <sub>C</sub> = 16 A, I <sub>B</sub> = (I <sub>C</sub> = 32 A, I <sub>B</sub> = (I <sub>C</sub> = 40 A, I <sub>B</sub> =	= 0.8 A) = 3.2 A)		VBE(sat)	_ _ _	_ _ _	2.5 2.9 3.3	Vdc
Diode Forward Vo	oltage		V <sub>f</sub>	_	_	4.0	Vdc
SWITCHING CHAI							1
Storage Time	T <sub>C</sub> = 25°C	See Table 1	t <sub>S</sub>	_	1.8	3.0	μs
Fall Time	1	I <sub>C</sub> = 32 A	t <sub>f</sub>	_	0.7	1.5	μs
Storage Time	T <sub>C</sub> = 100°C	I <sub>B1</sub> = 3.2 A	t <sub>S</sub>		2.2	_	μs
Fall Time	<b>1</b>	$V_{BE(off)} = 5 V$	t <sub>f</sub>		0.8	_	μs

<sup>(1)</sup> Pulse Test: PW = 300  $\mu$ s, Duty Cycle  $\leq$  2%.

### **TYPICAL CHARACTERISTICS**



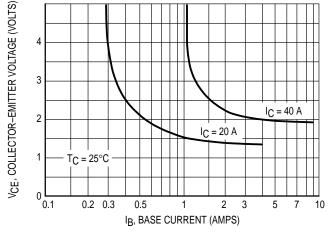
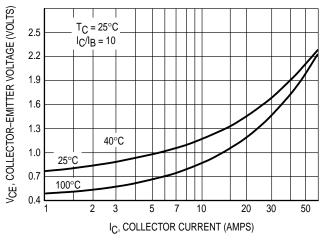


Figure 1. DC Current Gain

Figure 2. Collector Saturation Region



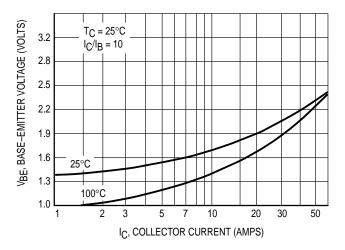


Figure 3. Collector-Emitter Saturation Voltage

Figure 4. Base-Emitter Voltage

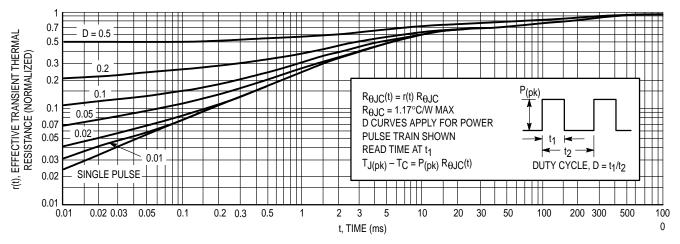


Figure 5. Thermal Response

**Table 1. Test Conditions for Dynamic Performance** 

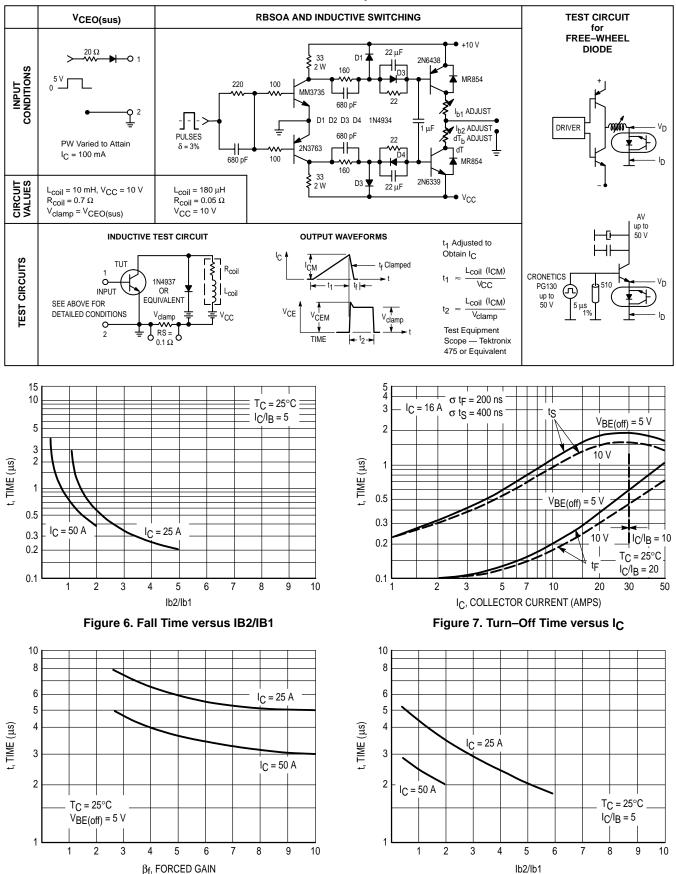


Figure 8. Storage Time versus Forced Gain

Figure 9. Storage Time versus Ib2/Ib1

### FREE-WHEEL DIODE CHARACTERISTICS

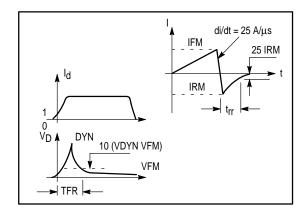


Figure 10. Free Wheel Diode Measurements

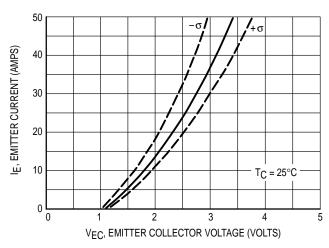


Figure 11. Forward Voltage

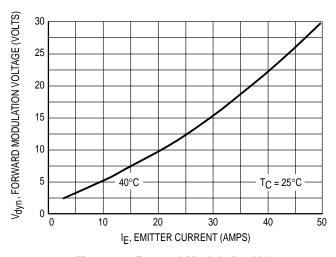


Figure 12. Forward Modulation Voltage

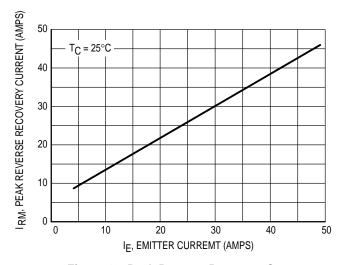


Figure 13. Peak Reverse Recovery Current

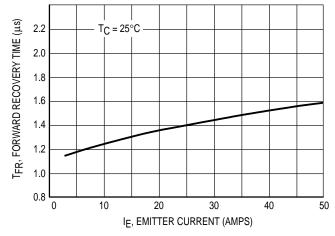


Figure 14. Forward Recovery Time

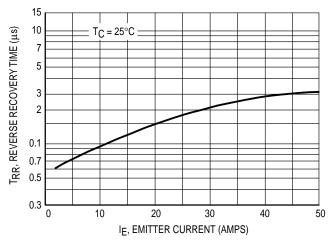


Figure 15. Reverse Recovery Time

### **BUT34**

The Safe Operating Area figures shown in Figures 16 and 17 are specifed for these devices under the test conditions shown.

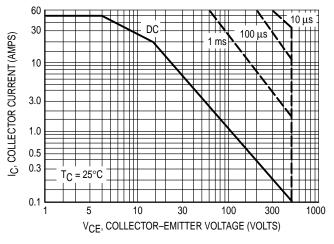


Figure 16. Safe Operating Area

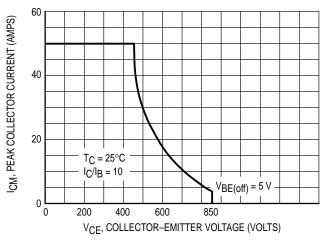


Figure 17. Reverse Bias Safe Operating Area

### SAFE OPERATING AREA INFORMATION

### **FORWARD BIAS**

There are two limitations on the power handling ability of a transistor: average junction temperature and second breakdown. Safe operating area curves indicate  $I_{\text{C}} - V_{\text{CE}}$  limits of the transistor that must be observed for reliable operation, i.e., the transistor must not be subject to greater dissipation than the curves indicate.

The data of Figure 16 is based on  $T_C=25^{\circ}C$ ;  $T_{J(pk)}$  is variable depending on power level. Second breakdown pulse limits are valid for duty cycles to 10% but must be derated when  $T_C \ge 25^{\circ}C$ . Second breakdown limitations do not derate the same as thermal limitations. Allowable current at the voltages shown on Figure 16 may be found at any case temperature by using the appropriate curve on Figure 18.

 $T_{J(pk)}$  may be calculated from the data in Figure 5. At high case temperatures, thermal limitations will reduce the power that can be handled to values less than the limitations imposed by second breakdown.

### **REVERSE BIAS**

For inductive loads, high voltage and high current must be sustained simultaneously during turn-off, in most cases, with the base to emitter junction reverse biased. Under these conditions the collector voltage must be held to a safe level at or below a specific value of collector current. This can be accomplished by several means such as active clamping, RC snubbing, load line shaping, etc. The safe level for these devices is specified as Reverse Bias Safe Operating Area and represents the voltage-current condition allowable during reverse biased turnoff. This rating is verified under clamped conditions so that the device is never subjected to an avalanche mode. Figure 17 gives the RBSOA characteristics.

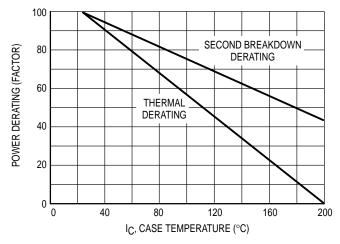
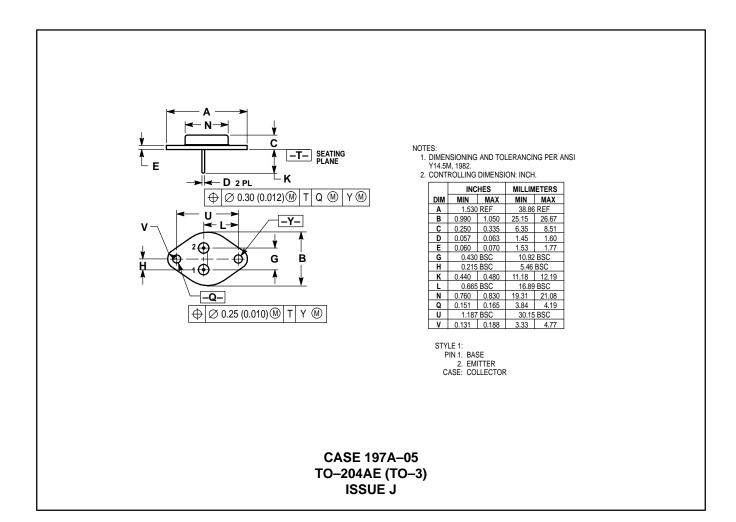


Figure 18. Power Derating

### **PACKAGE DIMENSIONS**



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